

## Product Summary

$V_{RRM}$	650 V
$I_F (T_c=155^\circ\text{C})$	10 A
$Q_c$	30 nC

## Features

- Low leakage current ( $I_R$ )
- Zero reverse recovery current
- Temperature independent switching behavior
- Positive temperature coefficient on  $V_F$
- High surge current capacity
- Low capacitive charge

## Benefits

- System cost savings due to smaller magnetics
- System efficiency improvement over Si diodes
- Reduction of heat sink requirements
- Enabling higher frequency
- Reduced EMI

## Applications

- Switch mode power supplies (SMPS)
- Uninterruptible power supplies
- Server/telecom power supplies
- Power factor correction
- Solar

## Package Pin Definitions

- Pin1,3 and backside - Cathode
- Pin2 - Anode

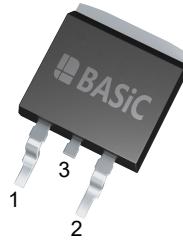
## Package Parameters

Part Number	Marking	Package
B2D10065F1	B2D10065F1	TO-263-3

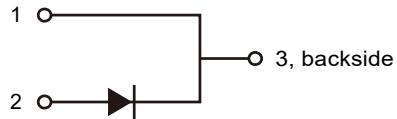
## Packing Quantities

Tape & Reel Packing	PCS/Reel	Reels/Box	PCS/Box
TO-263-3	800	1	800

## Package: TO-263-3



## Electrical Connection



Maximum Ratings ( $T_c=25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Test conditions	Value	Unit
$V_{RRM}$	Repetitive peak reverse voltage		650	V
$V_{RSM}$	Non-repetitive peak reverse voltage		650	V
$I_F$	Continuous forward current	$T_c=25^\circ\text{C}$	36	A
		$T_c=135^\circ\text{C}$	17	
		$T_c=155^\circ\text{C}$	10	
$I_{FSM}$	Non-repetitive forward surge current	$T_c=25^\circ\text{C}, t_p=10\text{ms}$ , Half sine wave	70	A
		$T_c=25^\circ\text{C}, t_p=10\mu\text{s}$ , Square-wave Pulse	570	
		$T_c=110^\circ\text{C}, t_p=10\mu\text{s}$ , Square-wave Pulse	530	
$\int i^2 dt$	$i^2t$ value	$T_c=25^\circ\text{C}, t_p=10\text{ms}$	24	A <sup>2</sup> S
$P_{tot}$	Power dissipation	$T_c=25^\circ\text{C}$ $T_c=110^\circ\text{C}$	145 63	W
$T_j$	Operating junction temperature		-55~175	°C
$T_{stg}$	Storage temperature		-55~175	°C

## Thermal Characteristics

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$R_{th(jc)}$	Thermal resistance from junction to case		1.03		K/W

### Electrical Characteristics

#### Static Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{DC}$	DC blocking voltage	$T_j=25^\circ C$	650			V
$V_F$	Diode forward voltage	$I_F=10A T_j=25^\circ C$ $I_F=10A T_j=175^\circ C$		1.31 1.7	1.5 2.4	V
$I_R$	Reverse current	$V_R=650V T_j=25^\circ C$ $V_R=650V T_j=175^\circ C$		1 20	70 200	$\mu A$

#### AC Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$Q_C$	Total capacitive charge	$V_R=400V T_j=25^\circ C$ $Q_C=\int_0^{V_R} C(V)dV$		30		nC
C	Total capacitance	$V_R=1V f=1MHz$ $V_R=300V f=1MHz$ $V_R=600V f=1MHz$		473 52 49		pF
$E_C$	Capacitance stored energy	$V_R=400V$		7.5		$\mu J$

### Typical Performance

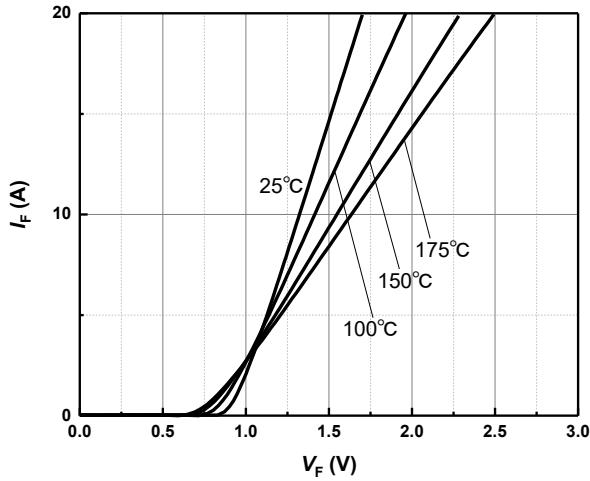


Figure 1 Typical forward characteristics

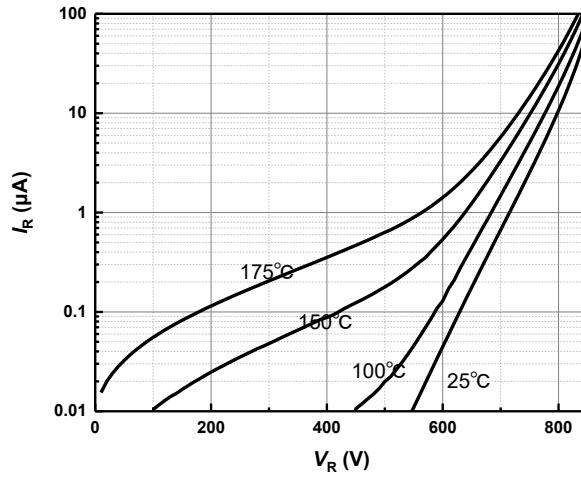


Figure 2 Typical reverse current as function of reverse voltage

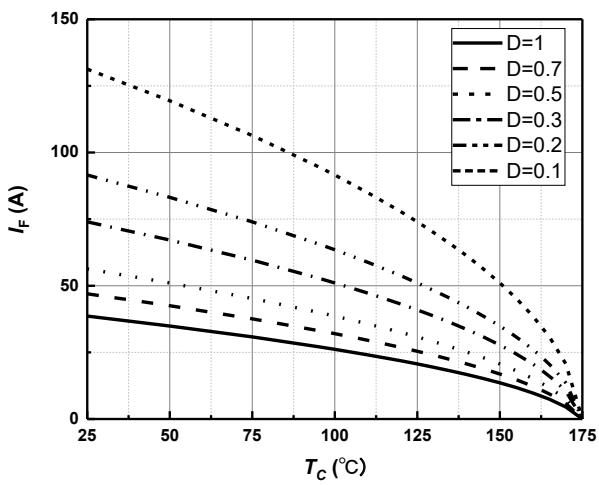


Figure 3 Diode forward current as function of temperature, D=duty cycle

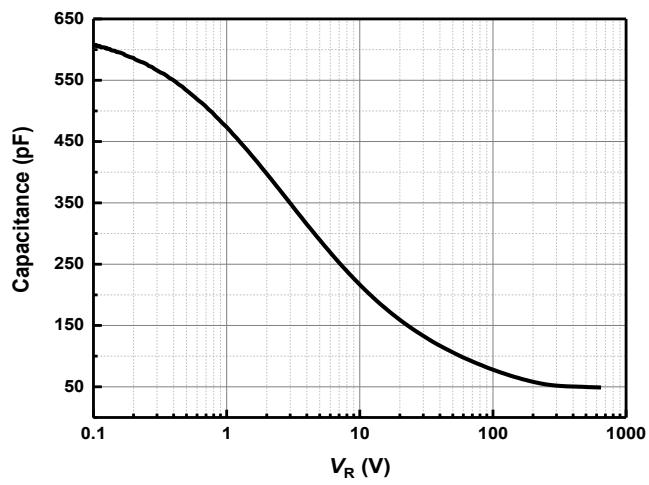
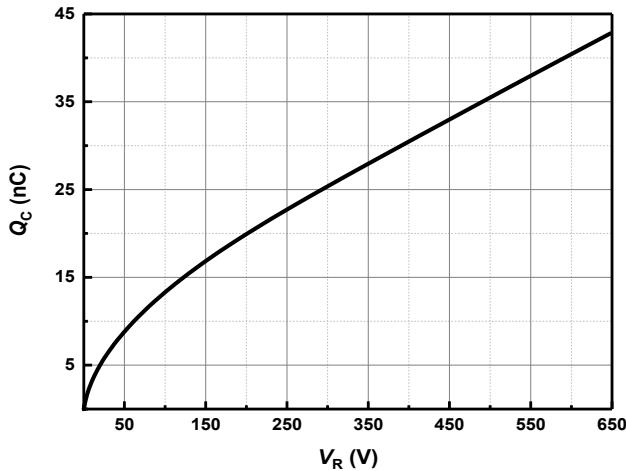
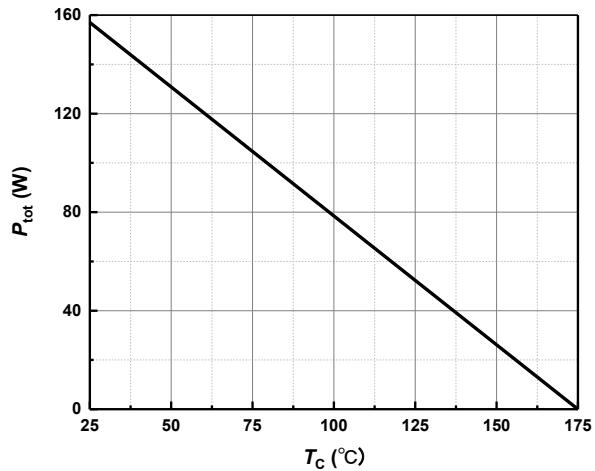


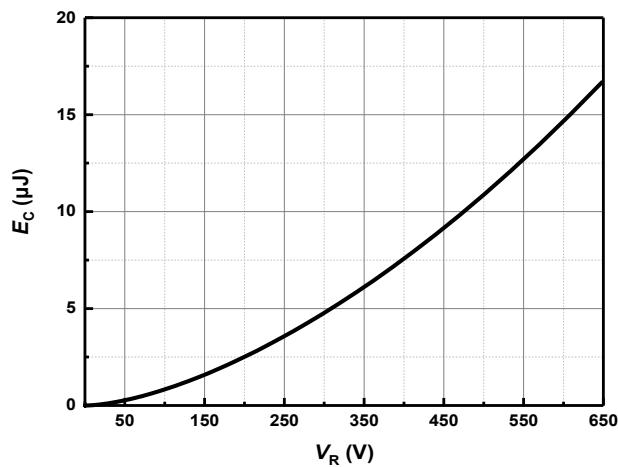
Figure 4 Typical capacitance as function of reverse voltage,  $C=f(V_R)$ ;  $T_j=25^\circ\text{C}$ ;  $f=1 \text{ MHz}$

**Typical Performance**


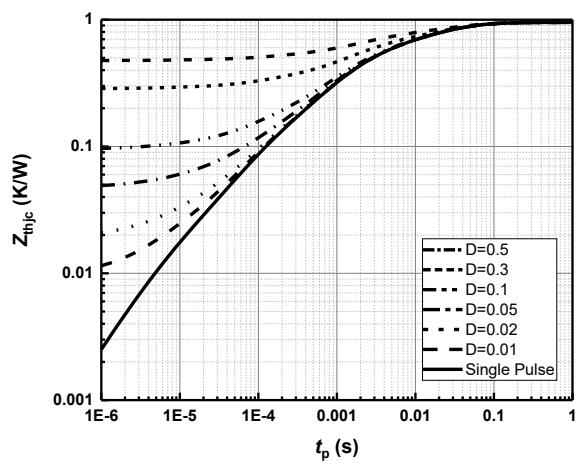
**Figure 5** Typical reverse charge as function of reverse voltage



**Figure 6** Power dissipation as function of case temperature



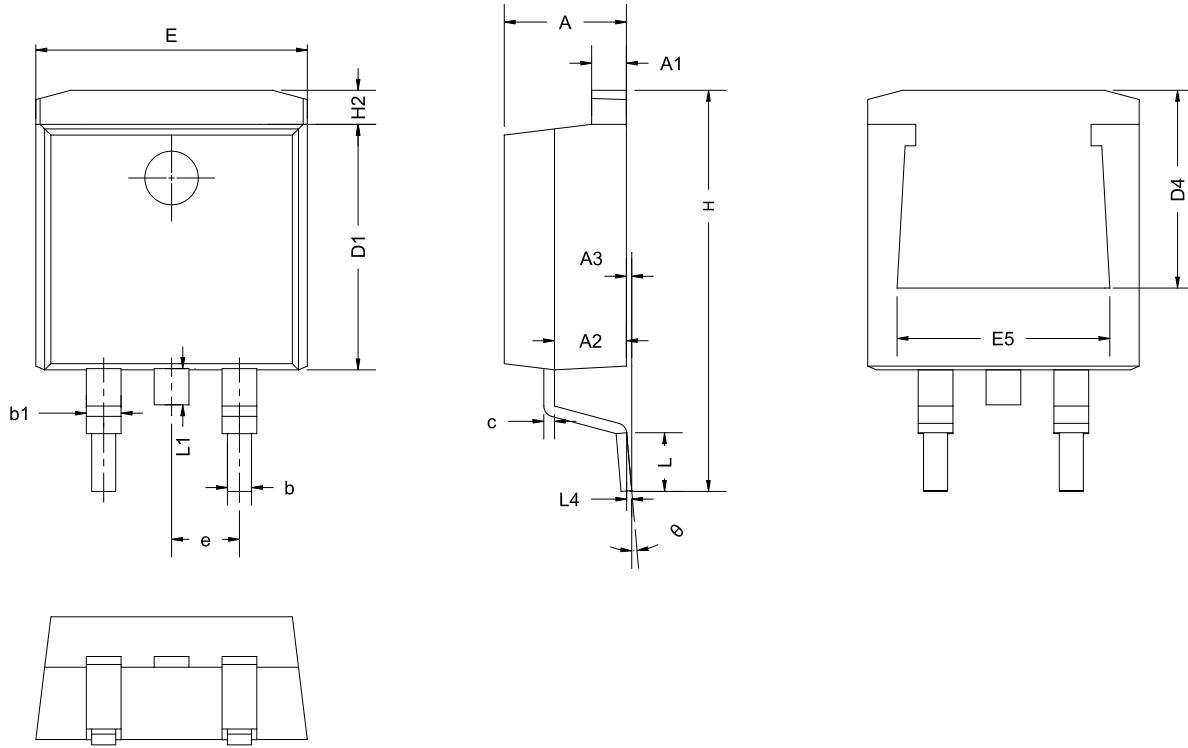
**Figure 7** Capacitance stored energy



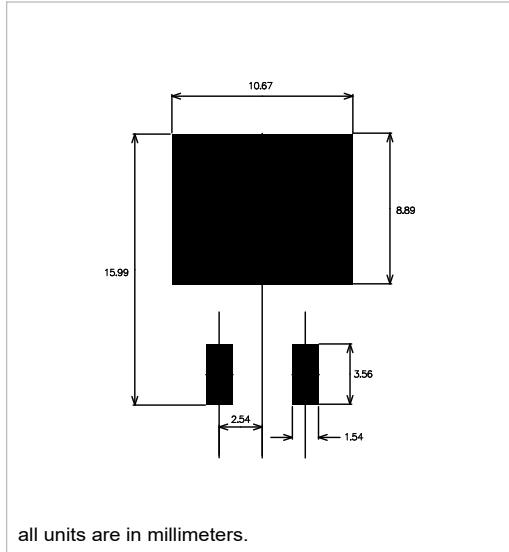
**Figure 8** Max. transient thermal impedance,  $Z_{thjc} = f(t)$ , parameter:  $D = t / T$



### Package Dimensions



### Recommended Solder Pad Layout



all units are in millimeters.

SYMBOL	mm		
	MIN	NOM	MAX
A	4.37	4.57	4.77
A1	1.22	1.27	1.42
A2	2.49	2.69	2.89
A3	0.00	0.13	0.25
b	0.70	0.81	0.96
b1	1.17	1.27	1.47
c	0.30	0.38	0.53
D1	8.50	8.70	8.90
D4	6.60	-	-
E	9.86	10.16	10.36
E5	7.06	-	-
e	2.44	2.54	2.64
H	14.70	15.10	15.50
H2	1.07	1.27	1.47
L	2.00	2.30	2.60
L1	1.40	1.55	1.70
L4	0.15	0.25	0.35
θ	0°	5°	9°

## Revision History

Document Version	Date of Release	Description of Changes
Rev. 0.0	2022-12-15	Release of the datasheet.
Rev. 0.1	2023-08-17	Characteristics updated.

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